

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/053,431	CHUNG ET AL.
	Examiner	Art Unit
	Hau H. Nguyen	2628

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
345	506, 557	8/11/2006	HN
345	542, 552	8/11/2006	HN
see attached			